

UCD4021B

Preliminary

CMOS IC

CMOS 8-STAGE STATIC SHIFT REGISTERS

■ DESCRIPTION

The **UCD4021B** is a 8-stage synchronous parallel or serial input/serial output registers having common CLOCK and PARALLEL/SERIAL CONTROL inputs, a SERIAL data input, and individual parallel inputs to each register stage. Each register is a D-type, master-slave flip-flop. Q6, Q7, and Q8 are outputs. In **UCD4021B** serial entry is synchronous with the clock but parallel entry is asynchronous.

In **UCD4021B** serial entry is controlled by the PARALLEL/SERIAL CONTROL input. When the PARALLEL/SERIAL CONTROL input is low, data is serially shifted into the 8-stage register synchronously with the positive transition of the clock line. When the PARALLEL/SERIAL CONTROL input is high, asynchronous parallel entry is made and the CLOCK input of the internal stage is isolated.

■ FEATURES

- * Up to 20V operation voltage
- * 12MHz (Typ.) clock rate at 10V
- * Maximum input current of 1µA at 18V
- * Fully static operation
- * 8 master-slave flip-flops plus output buffering and control gating

■ APPLICATIONS

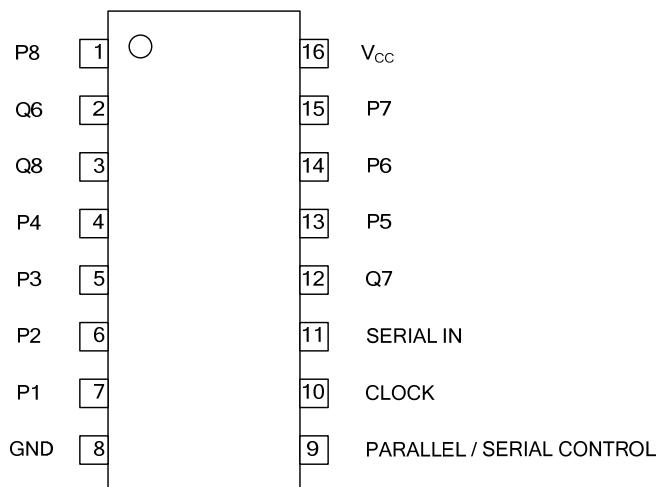
- * General-purpose register
- * Parallel input/serial output data queueing
- * Parallel to serial data conversion

■ ORDERING INFORMATION

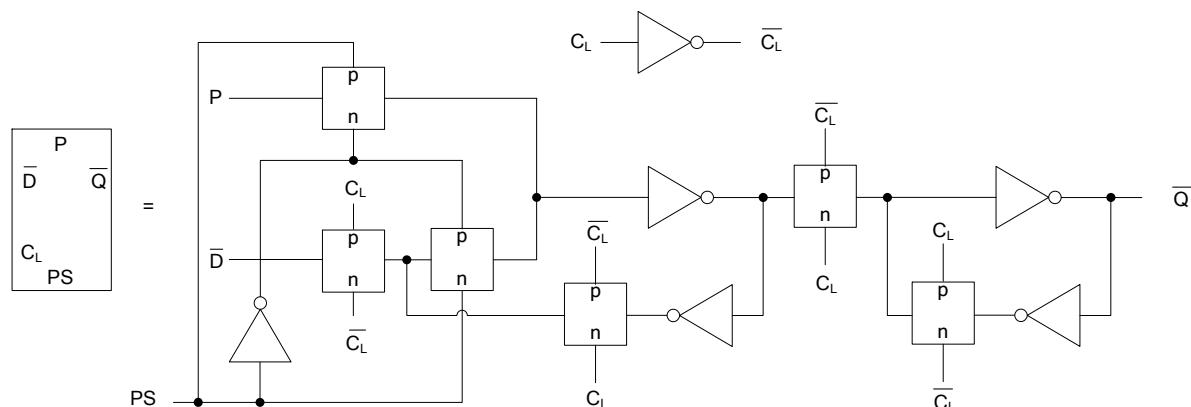
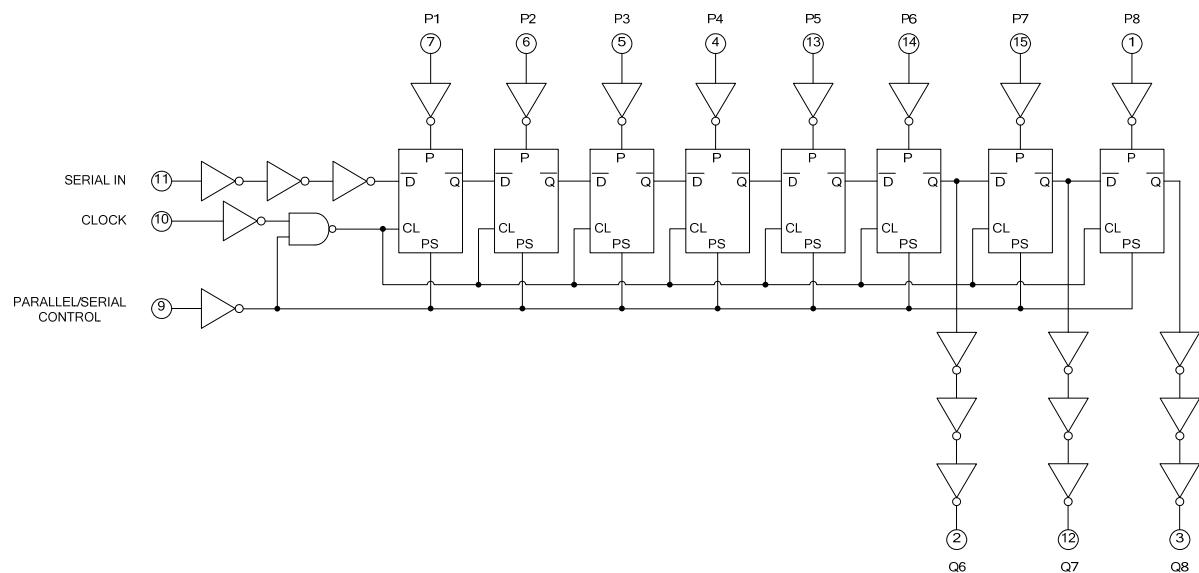
Ordering Number		Package	Packing
Lead Free	Halogen Free		
UCD4021BL-S16-R	UCD4021BG-S16-R	SOP-16	Tape Reel
UCD4021BL-S16-T	UCD4021BG-S16-T	SOP-16	Tube
UCD4021BL-P16-R	UCD4021BG-P16-R	TSSOP-16	Tape Reel
UCD4021BL-P16-T	UCD4021BG-P16-T	TSSOP-16	Tube

UCD4021BL-S16-R 	(1)Packing Type (2)Package Type (3)Lead Free	(1) T: Tube, R: Tape Reel (2) S16: SOP-16, P16: TSSOP-16 (3) L: Lead Free, G: Halogen Free
--	--	--

■ PIN CONFIGURATION



■ LOGIC DIAGRAM



■ TRUE TABLE

C_L	SER IN	PAR SER CONTROL	P_1	P_n	Q_1 (INTERNAL)	Q_n
X	X	1	0	0	0	0
X	X	1	0	1	0	1
X	X	1	1	0	1	0
X	X	1	1	1	1	1
↑	0	0	X	X	0	Q_{n-1}
↑	1	0	X	X	1	Q_{n-1}
↓	X	0	X	X	Q_1 (NC)	Q_n (NC)

NOTE: X = DON'T CARE CASE, NC = NO CHANGE

■ ABSOLUTE MAXIMUM RATING (unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V _{CC}	-0.5 ~ 20	V
Input Voltage	V _{IN}	-0.5 ~ V _{CC} + 0.5	V
Output Voltage	V _{OUT}	-0.5 ~ V _{CC} + 0.5	V
Input Clamp Current (V _{IN} <0, or V _{IN} >V _{CC})	I _{IK}	±10	mA
Power Dissipation	P _D	500 200	mW mW
Storage Temperature	T _{STG}	-65 ~ +150	°C

Note: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	SOP-16	θ _{JA}	73
TSSOP-16			108

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V _{CC}		3		18	V
Clock Pulse Width	t _W	V _{CC} = 5V V _{CC} = 10V V _{CC} = 15V	180 80 50			ns
Clock Frequency	f _{CL}	V _{CC} = 5V V _{CC} = 10V V _{CC} = 15V		3 6 8.5		
Clock Rise and Fall Time	t _{r, t_f}	V _{CC} = 5V V _{CC} = 10V V _{CC} = 15V		15 15 15		
Set-up Time, Serial Input	t _s	V _{CC} = 5V V _{CC} = 10V V _{CC} = 15V	120 80 60			ns
Set-up Time, Parallel Inputs		V _{CC} = 5V V _{CC} = 10V V _{CC} = 15V	50 30 20			
Parallel/Serial Pulse Width	t _W	V _{CC} = 5V V _{CC} = 10V V _{CC} = 15V	160 80 50			
Parallel/Serial Removal Time	t _{REM}	V _{CC} = 5V V _{CC} = 10V V _{CC} = 15V	280 140 100			ns

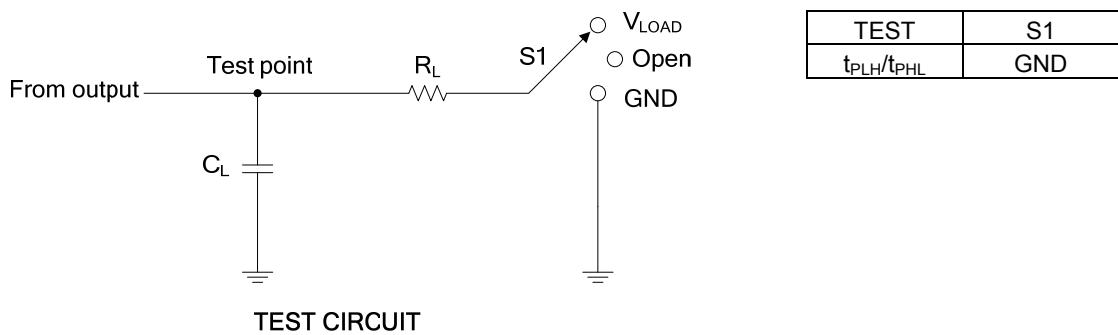
■ ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ C$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Quiescent Supply Current	I_{DD}	$V_{IN}=0, V_{DD}=5V$		0.04	5	μA
		$V_{IN}=0, 10V, V_{DD}=0V$		0.04	10	
		$V_{IN}=0, 15V, V_{DD}=15V$		0.04	20	
		$V_{IN}=0, 20V, V_{DD}=20V$		0.08	100	
Output Low (Sink) Current	I_{OL}	$V_{OUT}=0.4V, V_{IN}=0, 5V, V_{DD}=5V$	0.51	1		mA
		$V_{OUT}=0.5V, V_{IN}=0, 10V, V_{DD}=10V$	1.3	2.6		
		$V_{OUT}=1.5V, V_{IN}=0, 15V, V_{DD}=15V$	3.4	6.8		
Output High (Source) Current	I_{OH}	$V_{OUT}=4.6V, V_{IN}=0, 5V, V_{DD}=5V$	-0.51	-1		mA
		$V_{OUT}=2.5V, V_{IN}=0, 5V, V_{DD}=5V$	-1.6	-3.2		
		$V_{OUT}=9.5V, V_{IN}=0, 10V, V_{DD}=10V$	-1.3	-2.6		
		$V_{OUT}=3.5V, V_{IN}=0, 15V, V_{DD}=15V$	-3.4	-6.8		
Output Voltage: Low-Level	V_{OL}	$V_{IN}=0, 5V, V_{DD}=5V$		0	0.05	V
		$V_{IN}=0, 10V, V_{DD}=10V$		0	0.05	
		$V_{IN}=0, 15V, V_{DD}=15V$		0	0.05	
Output Voltage: High-Level	V_{OH}	$V_{IN}=0, 5V, V_{DD}=5V$	4.95	5		V
		$V_{IN}=0, 10V, V_{DD}=10V$	9.95	10		
		$V_{IN}=0, 15V, V_{DD}=15V$	14.95	15		
Input Low Voltage	V_{IL}	$V_{OUT}=0.5, 4.5V, V_{DD}=5V$			1.5	V
		$V_{OUT}=1, 9V, V_{DD}=10V$			3	
		$V_{OUT}=1.5, 13.5V, V_{DD}=15V$			4	
Input High Voltage	V_{IH}	$V_{OUT}=0.5, 4.5V, V_{DD}=5V$	3.5			V
		$V_{OUT}=1, 9V, V_{DD}=10V$	7			
		$V_{OUT}=1.5, 13.5V, V_{DD}=15V$	11			
Input Leakage Current	$I_{I(LEAK)}$	$V_{IN}=0, 18V, V_{DD}=18V$		$\pm 10^{-5}$	± 0.1	μA

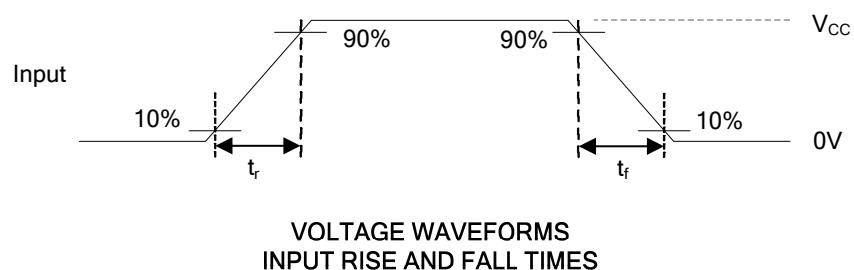
■ SWITCHING CHARACTERISTICS ($T_A = 25^\circ C$, Input $t_r, t_f = 20\text{ns}$, $C_L = 50\text{pF}$, $R_L = 200\text{k}\Omega$)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Propagation Delay Time	t_{PLH} / t_{PHL}	$V_{DD}=5\text{V}$		160	320	ns
		$V_{DD}=10\text{V}$		80	160	
		$V_{DD}=15\text{V}$		60	120	
Transition Time	t_{TTL} / t_{TTH}	$V_{DD}=5\text{V}$		100	200	ns
		$V_{DD}=10\text{V}$		50	100	
		$V_{DD}=15\text{V}$		40	80	
Maximum Clock Input Frequency	f_{CL}	$V_{DD}=5\text{V}$	3	6		MHz
		$V_{DD}=10\text{V}$	6	12		
		$V_{DD}=15\text{V}$	8.5	17		
Minimum Clock Pulse Width	t_W	$V_{DD}=5\text{V}$		90	180	ns
		$V_{DD}=10\text{V}$		40	80	
		$V_{DD}=15\text{V}$		25	50	
Clock Rise and Fall Time	t_r / t_f	$V_{DD}=5\text{V}$			15	μs
		$V_{DD}=10\text{V}$			15	
		$V_{DD}=15\text{V}$			15	
Minimum Setup Time, Serial Inputs	t_S	$V_{DD}=5\text{V}$		60	120	ns
		$V_{DD}=10\text{V}$		40	80	
		$V_{DD}=15\text{V}$		30	60	
Minimum Setup Time, Parallel Inputs	t_S	$V_{DD}=5\text{V}$		25	50	ns
		$V_{DD}=10\text{V}$		15	30	
		$V_{DD}=15\text{V}$		10	20	
Minimum Setup Time, Parallel/Serial Control	t_S	$V_{DD}=5\text{V}$		90	180	ns
		$V_{DD}=10\text{V}$		40	80	
		$V_{DD}=15\text{V}$		30	60	
Minimum Hold Time, Serial In, Parallel In, Parallel/Serial Control	t_H	$V_{DD}=5\text{V}$			0	ns
		$V_{DD}=10\text{V}$			0	
		$V_{DD}=15\text{V}$			0	
Minimum P/S Pulse Width	t_{WH}	$V_{DD}=5\text{V}$		80	160	ns
		$V_{DD}=10\text{V}$		40	80	
		$V_{DD}=15\text{V}$		25	50	
Minimum P/S Removal Time	t_{REM}	$V_{DD}=5\text{V}$		140	280	ns
		$V_{DD}=10\text{V}$		70	140	
		$V_{DD}=15\text{V}$		50	100	
Average Input Capacitance	C_I	Any Input		5	7.5	pF

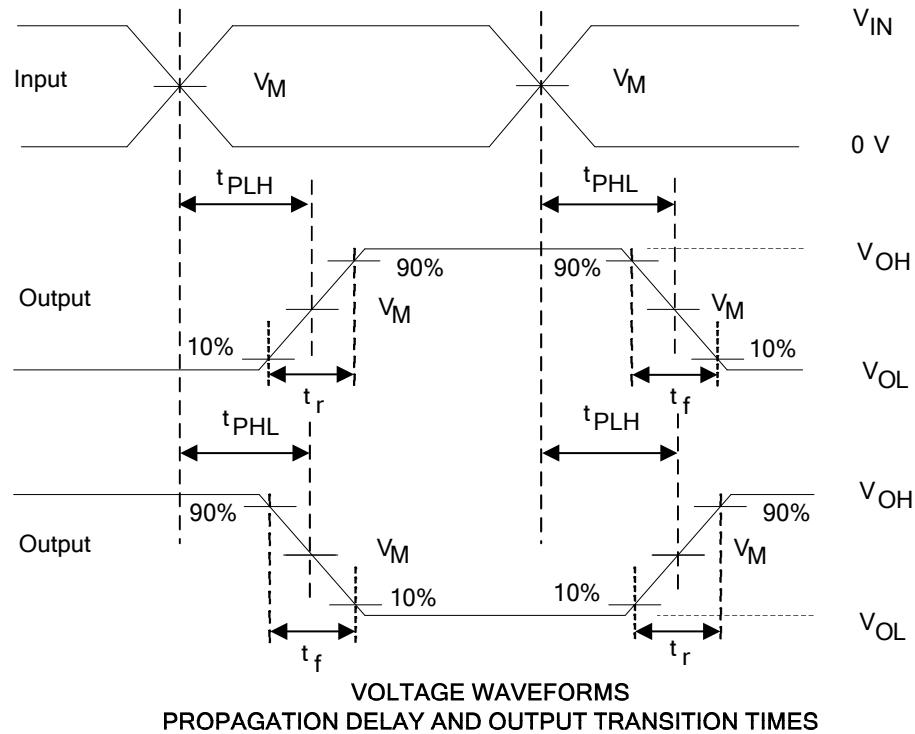
■ TEST CIRCUIT AND WAVEFORMS



INPUTS		V_M	V_{LOAD}	C_L	R_L
V_{IN}	t_r, t_f	$V_{CC}/2$	V_{CC}		
V_{CC}	20 ns			50 pF	200 K Ω

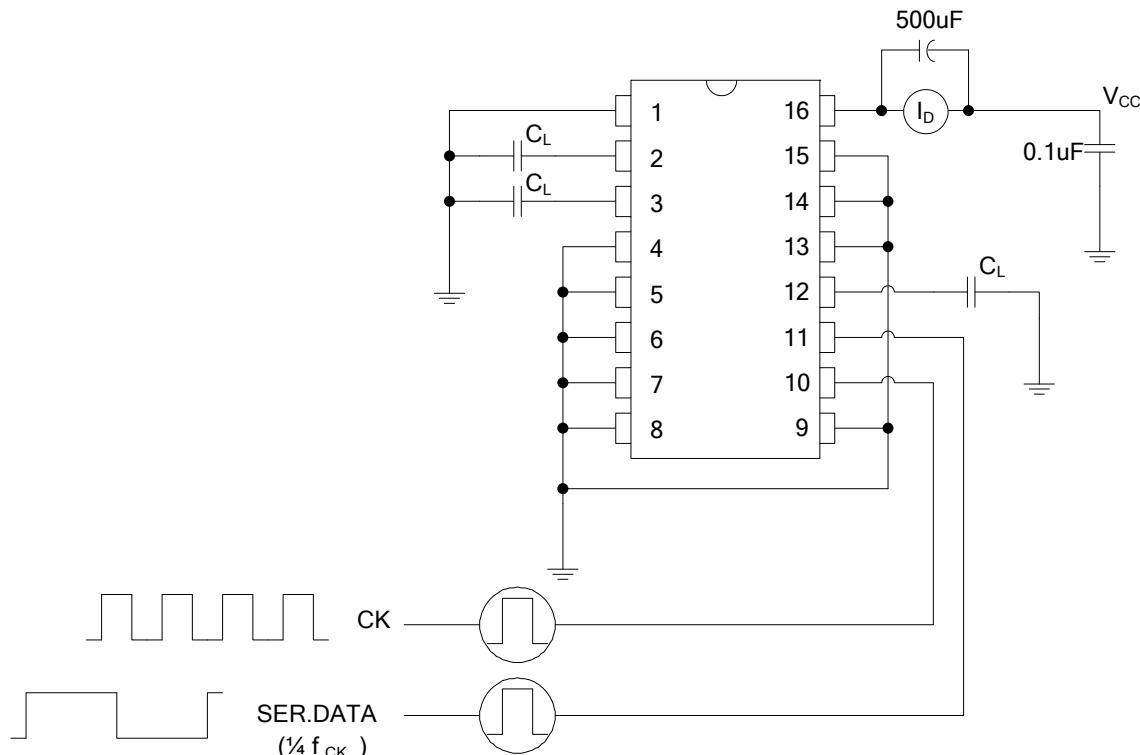


■ TEST CIRCUIT AND WAVEFORMS(Cont.)



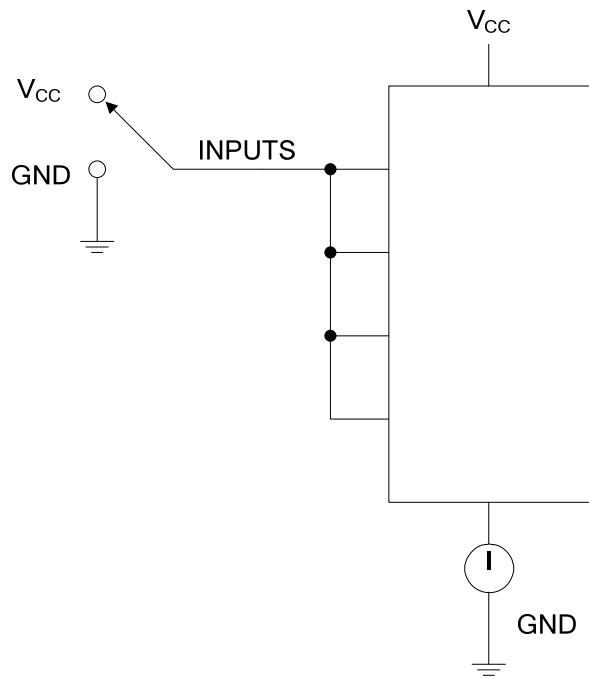
Notes: 1. C_L includes probe and jig capacitance.

2. All input pulses are supplied by generators having the following characteristics: PRR $\leq 1\text{MHz}$, $Z_0 = 50\Omega$.

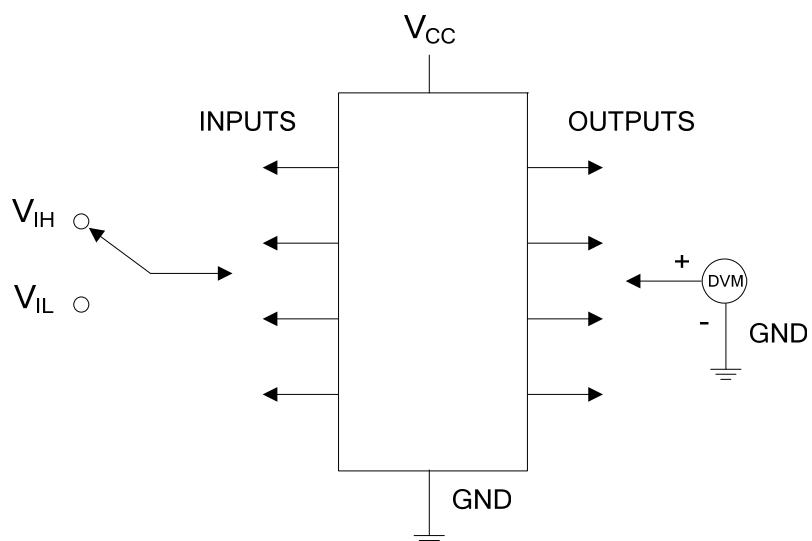


DYNAMIC POWER DISSIPATION TEST CIRCUIT

- TEST CIRCUIT AND WAVEFORMS(Cont.)

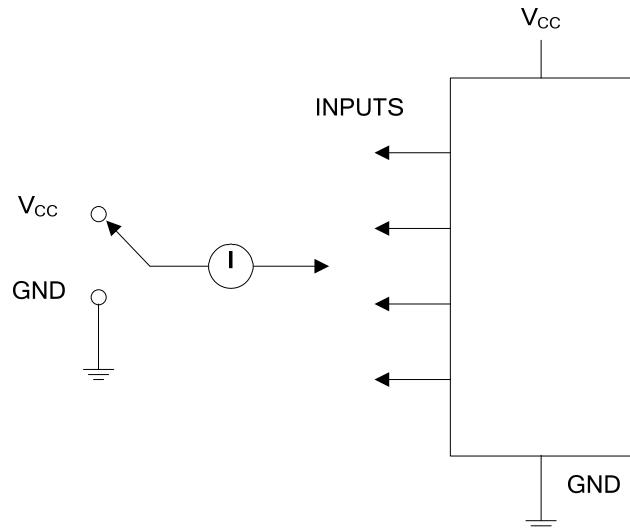


QUIESCENT DEVICE CURRENT TEST CIRCUIT



INPUT VOLTAGE TEST CIRCUIT

- TEST CIRCUIT AND WAVEFORMS(Cont.)



INPUT CURRENT TEST CIRCUIT

Note: measure inputs sequentially, to both V_{CC} and GND; connect all unused inputs to either V_{CC} or GND.

UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice.